

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/665,447	KANEKO, TSUYOSHI	
Examiner		Art Unit		Page 1 of 1
Phillip Nguyen		2828		

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-6,653,157 b2	11-2003	Kondo, Takayuki	438/22
B	US-5,838,715	11-1998	Corzine et al.	372/96
C	US-6,144,682	11-2000	Sun, Decai	372/45.01
D	US-5,256,596	10-1993	Ackley et al.	438/39
E	US-6,936,839	08-2005	Taylor, Geoff W.	257/20
F	US-6,590,917	07-2003	Nakayama et al.	372/45.01
G	US-6,160,834	12-2000	Scott, Jeffrey W.	372/96
H	US-6,865,214	03-2005	Kim, Taek	372/96
I	US-2002/0191659 A1	12-2002	Skogman, Richard A.	372/46
J	US-			
K	US-			
L	US-			
M	US-			

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
X	WO 02/45217 a2	06-2002	WIPO		
O					
P					
Q					
R					
S					
T					

NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
U			
V			
W			
X			

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.